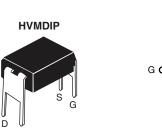
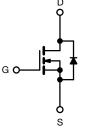


Power MOSFET





N-Channel MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	10	100				
R _{DS(on)} (Ω)	V _{GS} = 5 V	0.54				
Q _g (Max.) (nC)	6.	6.1				
Q _{gs} (nC)	2.0	2.6				
Q _{gd} (nC)	3.0	3.3				
Configuration	Sing	Single				

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- · For automatic insertion
- End stackable
- Logic-level gate drive
- R_{DS(on)} specified at V_{GS} = 4 V and 5 V
- 175 °C operating temperature
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION				
Package	HVMDIP			
Lead (Pb)-free	IRLD110PbF			

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	100	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Gate-source voltage			V_{GS}	± 10	V	
Continuous drain current	V -+ 5 V	T _A = 25 °C	- I _D	1	A	
	V _{GS} at 5 V	T _A = 100 °C		0.70		
Pulsed drain current ^a			I _{DM}	8	7	
Linear derating factor				0.0083	W/°C	
Single pulse avalanche energy b			E _{AS}	100	mJ	
Repetitive avalanche current a			I _{AR}	1	Α	
Repetitive avalanche energy ^a			E _{AR}	0.13	mJ	
Maximum power dissipation $T_A = 25 ^{\circ}C$		P_{D}	1.3	W		
Peak diode recovery dv/dt ^c			dV/dt	5.5	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	- 55 to + 175	- °C	
Soldering rRecommendations (peak temperature) d For 10 s				300 ^d	7	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 6.4 mH, R_g = 25 Ω , I_{AS} = 5.6 A (see fig. 12)
- c. $I_{SD} \le 5.6$ A, $dI/dt \le 75$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	120	°C/W	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static				L		L		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.12	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	1	-	2	V	
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 10 V	-	-	± 100	nA	
Zaus Cata Valtana Duain Courant	I _{DSS}	V _{DS} =	V _{DS} = 100 V, V _{GS} = 0 V		-	25		
Zero Gate Voltage Drain Current		V _{DS} = 80 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μA	
5 . 6 . 6 . 6		V _{GS} = 5 V	I _D = 0.60 A ^b	-	-	0.54		
Drain-Source On-State Resistance	$R_{DS(on)}$	V _{GS} = 4 V		-	-	0.76	Ω	
Forward Transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 0.60 A ^b	1.3	-	-	S	
Dynamic				I.		·	·	
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	250	-		
Output Capacitance	C _{oss}	1	$V_{DS} = 25 \text{ V},$	-	80	-	pF	
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz, see fig. 5		-	15	-	1	
Total Gate Charge	Qg		I _D = 5.6 A, V _{DS} = 80 V,	-	-	6.1	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 5 V		-	-	2.6		
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b		-	3.3	1	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 50 \text{ V, } I_D = 5.6 \text{ A,}$ $R_g = 12 \Omega, R_D = 8.4 \Omega, \text{ see fig. } 10^b$		-	9.3	-	- ns	
Rise Time	t _r			-	4.7	-		
Turn-Off Delay Time	t _{d(off)}			-	16	-		
Fall Time	t _f			-	17	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4	-		
Internal Source Inductance	L _S			-	6	-	- nH	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1	^	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	8	- A	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 1 A, V _{GS} = 0 V ^b		-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	T 05 %C 1	E C A -11/-1+ 100 A / -h	-	110	130	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 5.6 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^b$		-	0.50	0.65	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

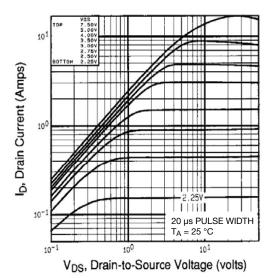


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

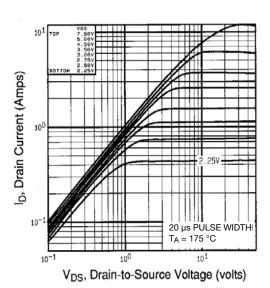


Fig. 1 - Typical Output Characteristics, T_A = 175 °C

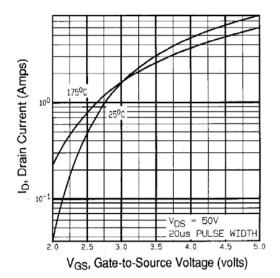


Fig. 2 - Typical Transfer Characteristics

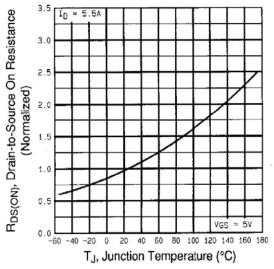


Fig. 3 - Normalized On-Resistance vs. Temperature



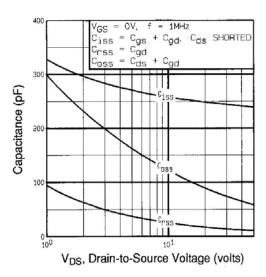


Fig. 4 - Typical Capacitance vs. Drain-to-Source Voltage

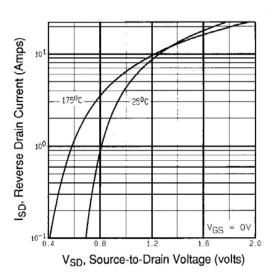


Fig. 6 - Typical Source-Drain Diode Forward Voltage

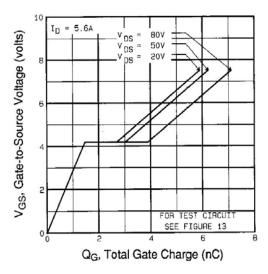


Fig. 5 - Typical Gate Charge vs. Gate-to-Source Voltage

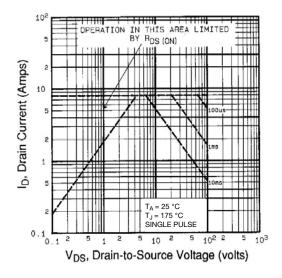


Fig. 7 - Maximum Safe Operating Area



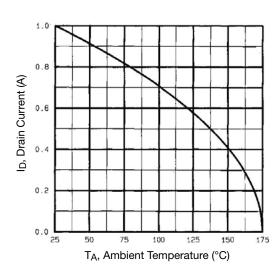


Fig. 8 - Maximum Drain Current vs. Ambient Temperature

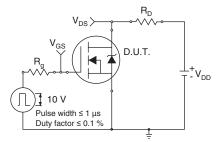


Fig. 9 - Switching Time Test Circuit

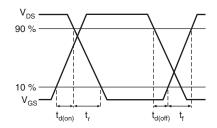


Fig. 10 - Switching Time Waveforms

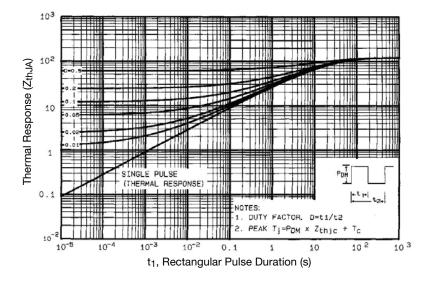


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



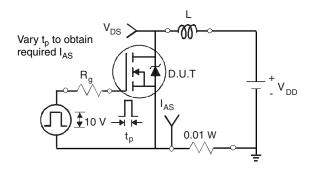


Fig. 12 - Unclamped Inductive Test Circuit

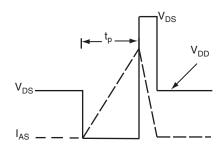


Fig. 13 - Unclamped Inductive Waveforms

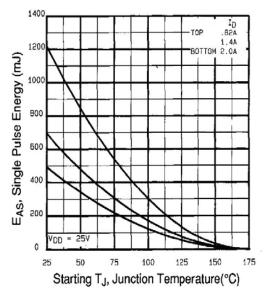


Fig. 14 - Maximum Avalanche Energy vs. Drain Current

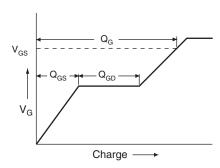


Fig. 15 - Basic Gate Charge Waveform

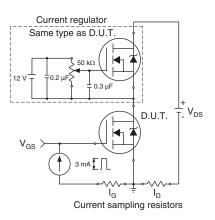
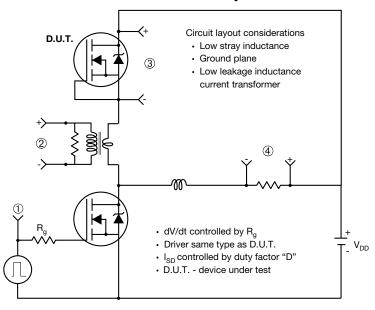


Fig. 16 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



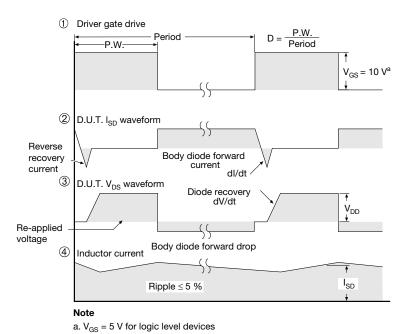
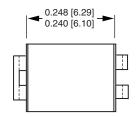


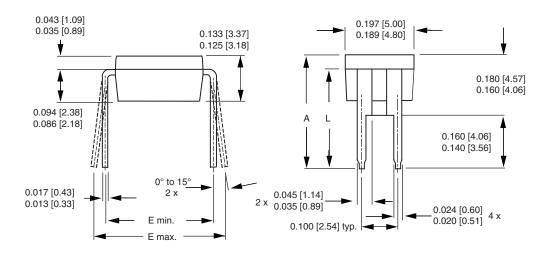
Fig. 17 - For N-Channel

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Vishay Siliconix

HVM DIP (High voltage)





	INCHES		INCHES MILLIMETERS		IETERS
DIM.	MIN.	MAX.	MIN.	MAX.	
A	0.310	0.330	7.87	8.38	
Е	0.300	0.425	7.62	10.79	
L	0.270	0.290	6.86	7.36	

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

Document Number: 91361 Revision: 06-Sep-10



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